

Application/Control No.	Applicant(s)/Patent under Reexamination
09/782,064	MOTOYAMA ET AL.
Examiner	Art Unit
Quoc A. Tran	2176

SEARCHED						
Class	Subclass	Date	Examiner			
399	1	12/28/2005	D			
709	202	12/28/2005				
709	224	12/28/2005				
709	218	6/29/2006				
358	1.14	6/29/2006	<u> </u>			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	l				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (US-PAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDBsee Search Histoty Printout	12/28/2005	D
ACM Digital Library DataBase	12/28/2005	
EAST (US-PAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB ee Search Histoty Printout	06/29/2006	